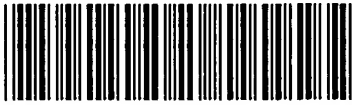


Search Notes

Application/Control No.

10/533,440

Examiner

Chris H. Chu

Applicant(s)/Patent under
Reexamination

ROSMAN ET AL.

Art Unit

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**SEARCH NOTES
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| applicants' cited references | 2/23/2006 | CC |
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| IEEE database | 2/24/2006 | CC |
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